## LIST OF PRIOR ART CITED BY APPLICANT

(Filed on April 15, 2005) JC12 Rec'd PCT/PTC 1 5 APR 2005

Docket No.

JG-SU-5213/500577.20067

Applicant(s):

Kazunari KURITA and Jun FURUKAWA

Application No.19/631, 434 (Int'l Appln No. PCT/JP2003/013320 170CT03)

, Filed: 00/14/2000

Group: 1/200 Examiner: HAeshew

## **U.S. PATENT DOCUMENTS**

Exam. Init		Document Number	Date	. Name	Class	Sub- Class	Filing Date Appropriate
KH	AA	6,045,610	04/04/2000	Park, et al.			
	AB					1	
	AC						
	AD						
	AE				-		
	AF						
	AG					<del> </del>	
	AH		·				
	Al			·			
	AJ						
	AK						<del>.</del>

## FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	CLASS	Sub- Class	Translation YES	NO
Fit.	AL	2 324 652	10/28/1998	Great Britain	-	_		-110
F.K.	AM	11-1393	06/01/1999	Japan	_		US 6,045,610	
F.H.	AN	2002-47094	02/12/2002	Japan			Abstract only	
	AO					<del>                                     </del>		
	AP.							
	AQ						1	
	AR					<del>                                     </del>	<del>                                     </del>	
	AS						<del>                                     </del>	
	AT				<del></del>	<del> </del>	<del>                                     </del>	

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AX Abstract only of Publication No. 2002-102385 published 13APR01, Mitsubishi Materials Silicon, "Silicon wafer without aggregate of dot-like defect"

AY

AZ

Examiner: Little Date: 3/2/07

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.